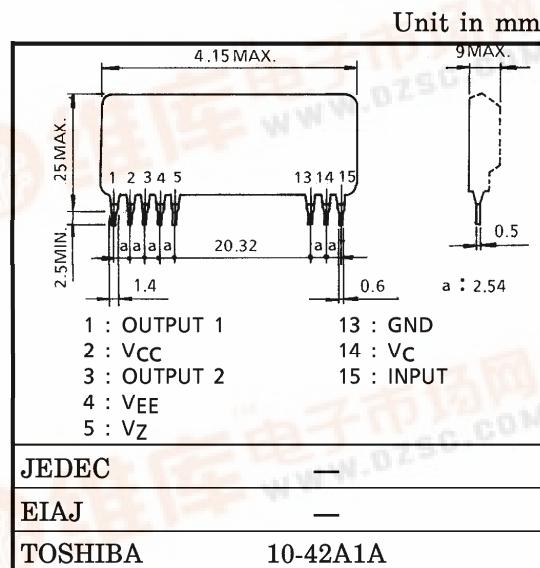


TOSHIBA SOLID STATE IGBT GATE DRIVER MODULE

TF1205

TOSHIBA TF1205 is the IGBT gate driver designed for use with TOSHIBA Insulated Gate Bipolar Transistor Module and it includes the optical isolator and IGBT gate driver circuit. Using this driver, you can design high reliability and compact system.

- Recommended Conditions :
 - Input Supply Voltage : $V_C = 5V$
 - Output Supply Voltage : $V_{CC} = 15V$, $V_{EE} = -15V$
- High Speed Switching Response :
 - $t_{PLH} = 0.5\mu s$ (Typ.)
 - $t_{PHL} = 0.4\mu s$ (Typ.)
- Small Size and Light Weight
- 2500 VAC Optical Isolation
- Including Input-Buffer



Weight : 8g

MAXIMUM RATINGS ($T_a = 25^\circ C$)

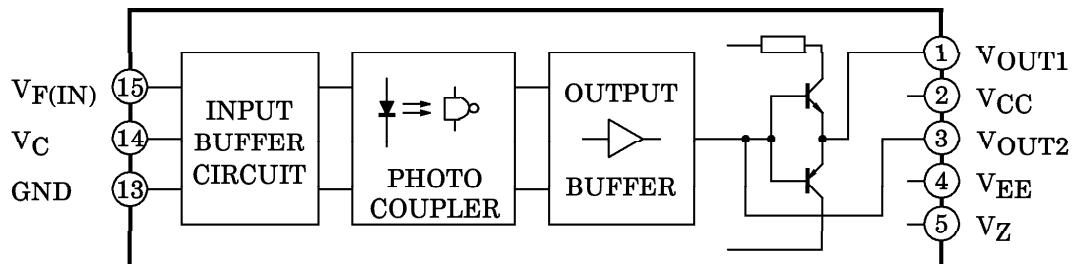
CHARACTERISTIC	SYMBOL	RATING	UNIT
Input Supply Voltage	V_C	6	V
Input Voltage	$V_F(IN)$	$-0.5 \sim V_C + 0.5$	
Output Supply Voltage	V_{CC}	18	V
	V_{EE}	-18	
Output Voltage	V_{OUT}	$V_{CC} \sim V_{EE}$	V
High Level Peak Output Current (Note 1)	I_{OHP}	$2(10\mu s)$	A
Low Level Peak Output Current (Note 1)	I_{OLP}	$-3(10\mu s)$	A
Operating Frequency (Note 2)	f	30	kHz
Isolation (Input-Output)	BV_S / AC	2500 (1min)	V
Operating Temperature	T_{opr}	$-20 \sim 70$	°C
Storage Temperature	T_{stg}	$-20 \sim 85$	°C
Lead Soldering Temperature	T_{sol}	$260^\circ C (10s)$	°C

Note 1 : Exponential Waveform ($f=15\text{kHz}$, Fig.1)Note 2 : $I_{OHP}=2A(5\mu s)$, $I_{OLP}=-3A(5\mu s)$, Exponential Waveform (Fig.1)

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BLOCK DIAGRAM



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$, $V_C = 5\text{V}$, $V_{CC} = 15\text{V}$, $V_{EE} = -15\text{V}$, $R_L = 500\Omega$, $f = 10\text{kHz}$)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
High Level Input Voltage	V_{FT}	$V_{OUT1} > 0\text{V}$ (Fig.2, 3)	0.5	1.5	—	V
High Level Input Current	I_{FT}	$V_{OUT1} > 0\text{V}$ (Fig.2, 3)	-1.0	-0.5	—	mA
Input Impedance	$Z_{(IN)}$	$V_F(\text{IN}) = 0$	—	10	—	$\text{k}\Omega$
High Level Output Voltage	V_{OH}	$V_F(\text{IN}) = 5 \rightarrow 0\text{V}$, $R_L = 200\Omega$ (Fig.2, 3)	13	13.5	—	V
Low Level Output Voltage	V_{OL}	$V_F(\text{IN}) = 0 \rightarrow 5\text{V}$, $R_L = 200\Omega$ (Fig.2, 3)	—	-13.5	-13	
High Level Supply Current	I_{CCH}	$V_F(\text{IN}) = 5 \rightarrow 0\text{V}$, $V_{OUT1} > 0\text{V}$ (Fig.2, 3)	—	25	—	mA
Low Level Supply Current	I_{CCL}	$V_F(\text{IN}) = 0 \rightarrow 5\text{V}$, $V_{OUT1} < 0\text{V}$ (Fig.2, 3)	—	20	—	
Zener Voltage (Coupler Supply)	V_Z	$I_Z = 20\text{mA}$, 4pin to 5pin	—	5.1	—	V
Propagation Delay Time to High Output Level	t_{pLH}	$V_F(\text{IN}) = 5 \rightarrow 0\text{V}$, $V_{OUT1} > 0\text{V}$ $R_L = 200\Omega$	—	0.5	1.0	μs
Output Rise Time	t_r	(Fig.2, 3)	—	0.25	—	
Propagation Delay Time to Low Output Level	t_{pHL}	$V_F(\text{IN}) = 0 \rightarrow 5\text{V}$, $V_{OUT1} < 0\text{V}$ $R_L = 200\Omega$	—	0.4	0.8	μs
Output Fall Time	t_f	(Fig.2, 3)	—	0.10	—	
Common Mode Transient Immunity at Logic High Output	CM_H	$V_{CM} = 400\text{V}$	1	10	—	$\text{kV}/\mu\text{s}$
Isolation Resistance (Input-Output)	R_S	$V = 1\text{kV}$, $RH = 40 \sim 60\%$	—	10^{10}	—	Ω

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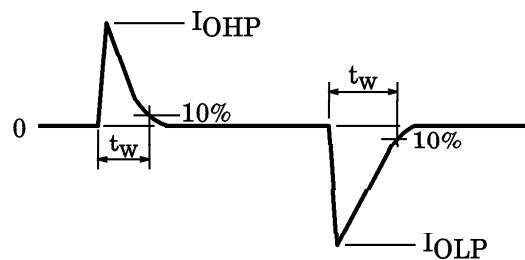


Fig.1 EXPONENTIAL WAVEFORM

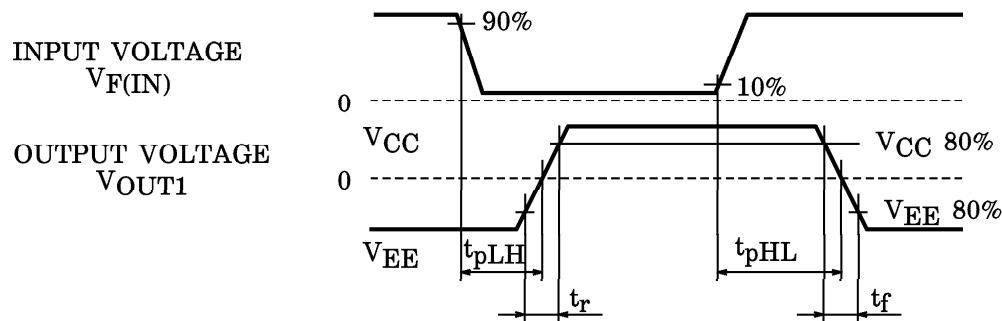


Fig.2 SWITCHING TIME TEST CONDITION

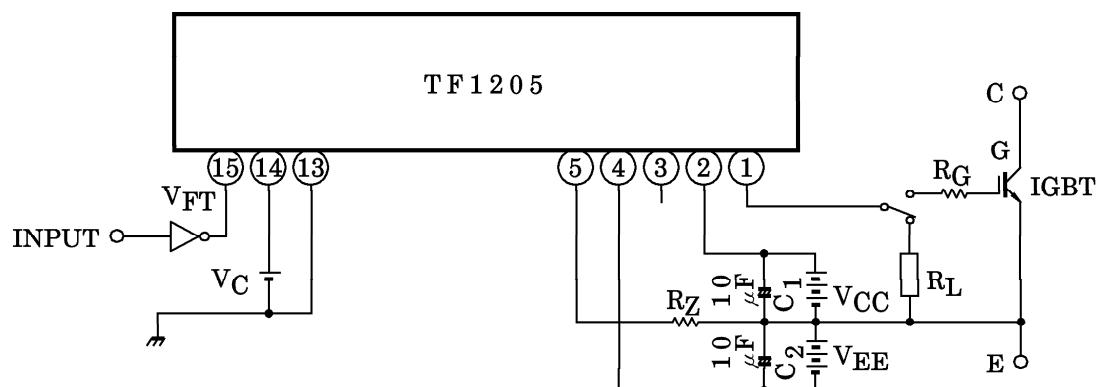


Fig.3 SWITCHING TIME TEST CIRCUIT

